

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination
		10/088,407	GRUTKE ET AL.
Examiner	Katarzyna Wyrozebski Lee	Art Unit	1714

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,492,452	12-2002	Topolkaraev et al.	524/445
B	US-6,395,386	05-2002	Bagrodia et al.	428/323
C	US-6,018,004	01-2000	Warzelhan et al.	525/440
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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